

Freeform Search

Database:	US Pre-Grant Publication Full-Text Database
	US Patents Full-Text Database
	US OCR Full-Text Database
	EPO Abstracts Database
	JPO Abstracts Database
	Derwent World Patents Index
	IBM Technical Disclosure Bulletins

Term:	16 and L16
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Display:	<input type="text" value="20"/> Documents in	Display Format:	<input type="text" value="-"/>	Starting with Number	<input type="text" value="1"/>
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result set

DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=ADJ

<u>L17</u>	16 and L16	8	<u>L17</u>
<u>L16</u>	112 and L15	169	<u>L16</u>
<u>L15</u>	18 and L14	5633	<u>L15</u>
<u>L14</u>	degree\$ near3 value\$	49498	<u>L14</u>
<u>L13</u>	17 and L12	15	<u>L13</u>
<u>L12</u>	707/\$.ccls.	34700	<u>L12</u>
<u>L11</u>	19 or L10	26	<u>L11</u>
<u>L10</u>	L7 and (personal near3 information)	9	<u>L10</u>
<u>L9</u>	17 and L8	17	<u>L9</u>
<u>L8</u>	(met or meet or satisf\$) near3 (condition\$ or criteria or criterion)	262827	<u>L8</u>
<u>L7</u>	14 and L6	100	<u>L7</u>
<u>L6</u>	(search\$ or quer\$ or retriev\$) near5 (target near3 information)	1870	<u>L6</u>
<u>L5</u>	(search\$ or quer\$ or retriev\$) near5 (target near3 infromation)	0	<u>L5</u>
<u>L4</u>	L3 and (search\$ or quer\$ or retriev\$)	44354	<u>L4</u>
<u>L3</u>	(control near5 (keyword\$ or term\$ or parameter\$))	169549	<u>L3</u>

DB=USPT; PLUR=YES; OP=ADJ

L2 (5873080 or 6230204 or 5850433 or 5946678).pn.

4 L2

L1 (5873080 or 6230204 or 5850433).pn.

3 L1

END OF SEARCH HISTORY

Refine Search

Search Results -

Terms	Documents
L7 and L12	15

Database:

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Search:

L13

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<u>L13</u>	17 and L12	15	<u>L13</u>
<u>L12</u>	707/\$.ccls.	34700	<u>L12</u>
<u>L11</u>	19 or L10	26	<u>L11</u>
<u>L10</u>	L7 and (personal near3 information)	9	<u>L10</u>
<u>L9</u>	17 and L8	17	<u>L9</u>
<u>L8</u>	(met or meet or satisf\$) near3 (condition\$ or criteria or criterion)	262827	<u>L8</u>
<u>L7</u>	14 and L6	100	<u>L7</u>
<u>L6</u>	(search\$ or quer\$ or retriev\$) near5 (target near3 information)	1870	<u>L6</u>
<u>L5</u>	(search\$ or quer\$ or retriev\$) near5 (target near3 infromation)	0	<u>L5</u>
<u>L4</u>	L3 and (search\$ or quer\$ or retriev\$)	44354	<u>L4</u>
<u>L3</u>	(control near5 (keyword\$ or term\$ or parameter\$))	169549	<u>L3</u>
<i>DB=USPT; PLUR=YES; OP=ADJ</i>			
<u>L2</u>	(5873080 or 6230204 or 5850433 or 5946678).pn.	4	<u>L2</u>
<u>L1</u>	(5873080 or 6230204 or 5850433).pn.	3	<u>L1</u>

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Search >☐ Check to search only within this results set

Display Format:



Citation



Citation & Abstract

» Key

IEEE JNL IEEE Journal or Magazine

IEE JNL IEE Journal or Magazine

IEEE CNF IEEE Conference Proceeding

IEE CNF IEE Conference Proceeding

IEEE STD IEEE Standard

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